

ASC OP 1 Wavefront Measurement Draft Standard Phone Conference Attendance Confirmation

Meeting Date	Last	First	Company	Participation	Primary	Means	
11/30/07	Aikens	David	Sawy Optics Corp.	Member	Primary	by Phone	
11/30/07	Boulton	Gordon	JDSU	Member	Alternate	Absent	
11/30/07	Brunfeld	Andrei	Xyratex	Member	Primary	by Phone	
11/30/07	Catching	Benjamin	JDSU	Member	Primary	by Phone	
11/30/07	Dowell	Marla	IEEE/LEOS (NIST)	Member	Primary	Absent	
11/30/07	Endelman	Lincoln	SPIE (Endelman Enterprises)	Member	Primary	by Phone	
11/30/07	Takacs	Peter	Brookhaven National Lab.	Member	Primary	by Phone	
11/30/07	VanKerkhove	Steven	Corning Tropel	Member	Primary	by Phone	
11/30/07	Assoufid	Lahsen	Argonne National Laboratory	Observer	Primary	by Phone	
11/30/07	Martinek	Stephen	4D Technology Corporation	Observer	Primary	by Phone	
11/30/07	Yashchuk	Valeriy	Lawrence Berkeley National Lab	Member	Primary	by Phone	
11/30/07	Martin	Gene	ASML	Observer	Primary	by Phone	
11/30/07	Gupta	Krishna	Zygo Corporation	Member	Alternate	by Phone	
						Means	
						Absent	2
						by Phone	11
						Total Result	13